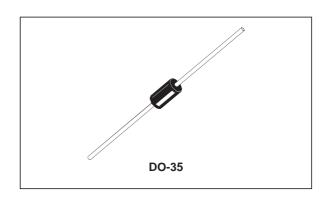


# SMALL SIGNAL SCHOTTKY DIODE

### **DESCRIPTION**

Metal to silicon junction diode featuring high breakdown, low turn-on voltage and ultrafast switching. Primarly intended for high level UHF/VHF detection and pulse application with broad dynamic range.



# **ABSOLUTE RATINGS** (limiting values)

Symbol	Parameter	Value	Unit
$V_{RRM}$	Repetitive Peak Reverse Voltage	60	V
I <sub>F</sub>	Forward Continuous Current*	15	mA
I <sub>FSM</sub>	Surge non Repetitive Forward Current*	50	mA
T <sub>stg</sub> Tj	Storage and Junction Temperature Range	- 65 to 200 - 65 to 200	°C
$T_L$	Maximum Lead Temperature for Soldering dur from Case	230	°C

## THERMAL RESISTANCE

Symbol	Test Conditions	Value	Unit
R <sub>th(j-a)</sub>	Junction-ambient*	400	°C/W

# **ELECTRICAL CHARACTERISTICS**

# STATIC CHARACTERISTICS

Symbol	Test Conditions				Тур.	Max.	Unit
$V_{BR}$	T <sub>amb</sub> = 25°C	$I_R = 10\mu A$		60			٧
V <sub>F</sub> * *	T <sub>amb</sub> = 25°C	I <sub>F</sub> = 1mA				0.41	V
	T <sub>amb</sub> = 25°C	$I_F = 15mA$				1	
I <sub>R</sub> * *	T <sub>amb</sub> = 25°C	V <sub>R</sub> = 50V				0.2	μΑ

### DYNAMIC CHARACTERISTICS

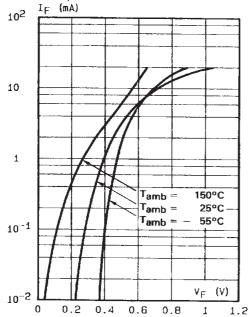
Symbol	Test Conditions			Min.	Тур.	Max.	Unit
С	T <sub>amb</sub> = 25°C	$V_R = 0V$	f = 1MHz			2.2	pF
τ	T <sub>amb</sub> = 25°C	$I_F = 5mA$	Krakauer Method			100	ps

<sup>\*</sup> On infinite heatsink with 4mm lead length \*\* Pulse test:  $t_p \! \leq \! 300 \mu s \; \delta \! < \! 2\%$ 

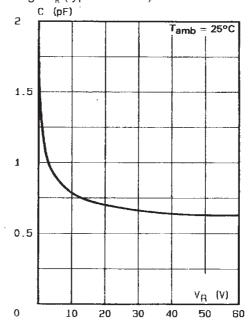
Matched batches available on request. Test conditions (forward voltage and/or capacitance) according to customer specification.

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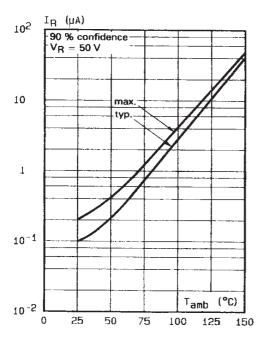
**Fig. 1:** Forward current versus forward voltage (typical values).



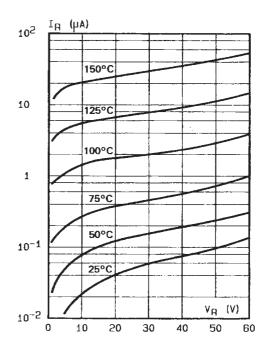
**Fig. 2:** Capacitance C versus reverse applied voltage  $V_{\scriptscriptstyle R}$  (typical values).



**Fig. 3:** Reverse current versus ambient temperature.



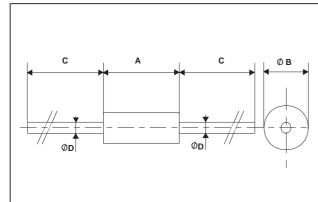
**Fig. 4:** Reverse current versus continuous reverse voltage (typical values).



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### **PACKAGE MECHANICAL DATA**

DO-35



REF.	DIMENSIONS				
	Millimeters		Inc	hes	
	Min.	Max.	Min.	Max.	
А	3.05	4.50	0.120	0.177	
В	1.53	2.00	0.060	0.079	
С	28.00		1.102		
D	0.458	0.558	0.018	0.022	

Cooling method: by convection and conduction

Marking: clear, ring at cathode end.

Weight: 0.15g

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